

# **MOSFET** - Power, Single **N-Channel** 40 V, 2.4 mΩ, 136 A

# **NVTFS002N04C**

#### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS002N04C Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	Э		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	136	Α
Current R <sub>θJC</sub> (Notes 1, 2, 3, 4)	Steady	T <sub>C</sub> = 100°C		77	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	85	W
R <sub>θJC</sub> (Notes 1, 2, 3)		T <sub>C</sub> = 100°C		27	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	27	Α
Current R <sub>0JA</sub> (Notes 1, 3, 4)	Steady	T <sub>A</sub> = 100°C		19	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	3.2	W
R <sub>θJA</sub> (Notes 1, 3)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	676	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	70.4	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 10.2 A)			E <sub>AS</sub>	268	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

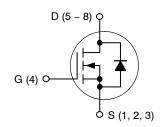
## THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.5	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
   Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
40 V	2.4 mΩ @ 10 V	136 A

#### N-Channel



#### **MARKING DIAGRAM**



WDFN8 (μ8FL) **CASE 511DY** 

SI n S D AYWW= S D G D

WDFNW8 CASE 515AP

> = Specific Device Code = Assembly Location = Year

WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-	-			-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	= 250 μA	40			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
		$V_{DS} = 40 \text{ V}$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 90 μΑ	2.5		3.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>E</sub>	<sub>)</sub> = 50 A		2.0	2.4	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>E</sub>	<sub>)</sub> = 50 A		92		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				2250		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = V <sub>DS</sub> = 25	1.0 MHz, 5 V		1230		1
Reverse Transfer Capacitance	C <sub>rss</sub>	VDS - 23 V			41		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V, I <sub>D</sub> = 50 A			6.7		nC
Gate-to-Source Charge	$Q_{GS}$				11.4		1
Gate-to-Drain Charge	$Q_{GD}$				5.7		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V, I <sub>D</sub> = 50 A			34		nC
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t <sub>d(on)</sub>				11		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	s = 32 V,		77		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10 \text{ V, } V_{D}$ $I_{D} = 50$	Ă		23		
Fall Time	t <sub>f</sub>	1			7		
DRAIN-SOURCE DIODE CHARACTEF	RISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$			0.84	1.2	V
			T <sub>J</sub> = 125°C		0.72		
Reverse Recovery Time	t <sub>RR</sub>		•		50		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, } dl_S/dt = 100 \text{ A/}\mu\text{s,}$ $l_S = 50 \text{ A}$			25		
Discharge Time	t <sub>b</sub>				25		
Reverse Recovery Charge	Q <sub>RR</sub>				50		nC

<sup>5.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

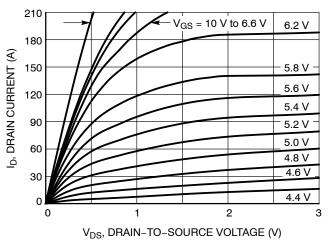


Figure 1. On-Region Characteristics

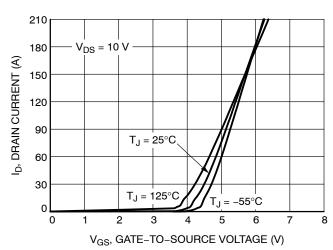


Figure 2. Transfer Characteristics

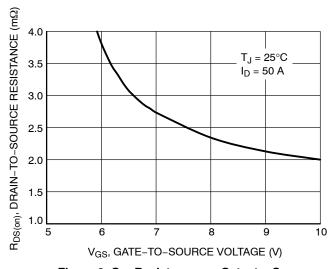


Figure 3. On-Resistance vs. Gate-to-Source Voltage

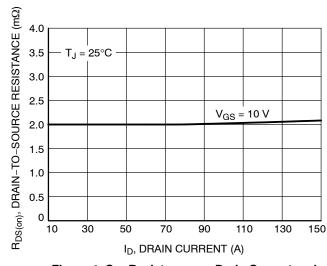


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

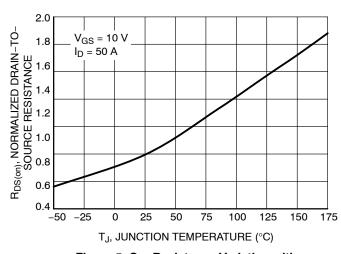


Figure 5. On–Resistance Variation with Temperature

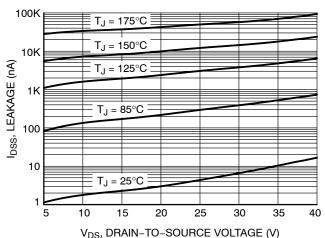


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

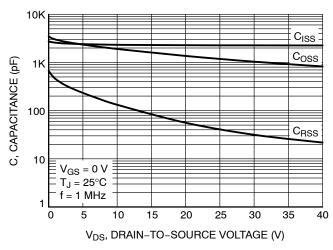


Figure 7. Capacitance Variation

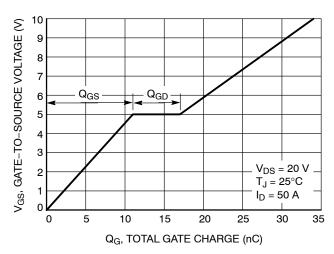


Figure 8. Gate-to-Source Voltage vs. Total Charge

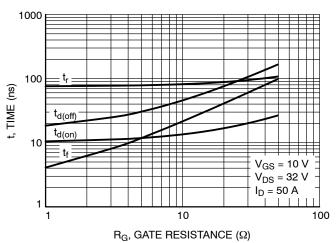


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

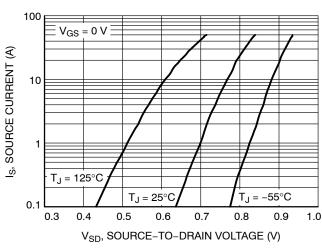


Figure 10. Diode Forward Voltage vs. Current

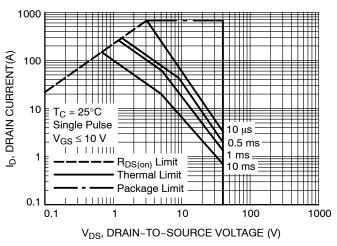


Figure 11. Maximum Rated Forward Biased Safe Operating Area

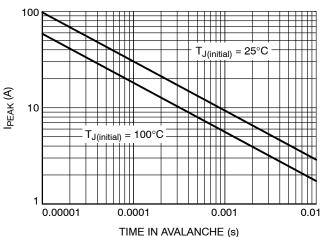


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

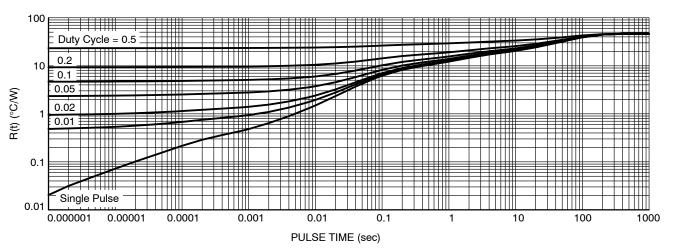


Figure 13. Thermal Characteristics

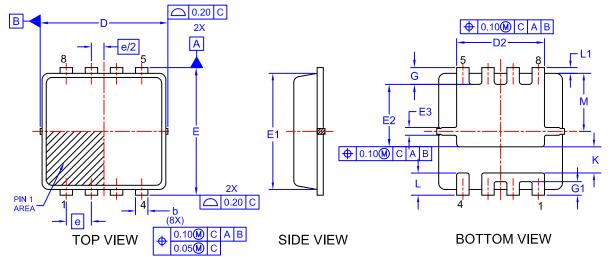
## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS002N04CTAG	02NC	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS002N04CTAG	02NW	WDFNW8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

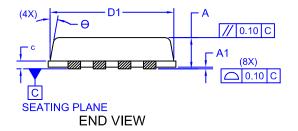
#### WDFN8 3.3x3.3, 0.65P CASE 511DY ISSUE A

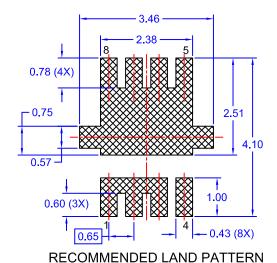
**DATE 21 AUG 2018** 



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETERS
- 2. DIMENSIONS D1 & E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.





# GENERIC MARKING DIAGRAM\*

O XXXX AYWW

XXXX = Specific Device Code A = Assembly Location

Y = Year Code WW = Work Week Code

l <sub>DIM</sub>	MILI	RS	
DIIVI	MIN	NOM	MAX
Α	0.70	0.75	0.80
A1	0.00	-	0.05
b	0.23	0.33	0.43
С	0.15	0.20	0.25
D	3.20	3.30	3.40
D1	2.95	3.13	3.30
D2	1.98	2.20	2.40
E	3.20	3.30	3.40
E1	2.80	3.00	3.15
E2	1.40	1.60	1.80
E3	0.15	0.25	0.40
е	0	.65 BS	С
G	0.30	0.43	0.55
G1	0.25	0.35	0.45
K	0.55	0.75	0.95
L	0.35	0.52	0.65
L1	0.06	0.15	0.30
М	1.35	1.50	1.60
θ	0	-	12

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.3x3.3, 0.65P		PAGE 1 OF 1

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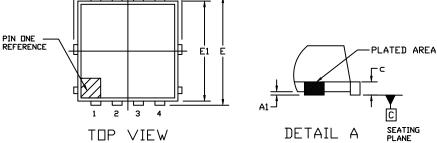
#### WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL Fused WF) CASE 515AP

**ISSUE O** 

#### **DATE 25 AUG 2020**

#### NOTES:

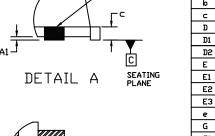
- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

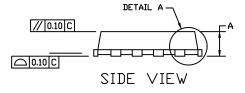


B

-<u>A</u>

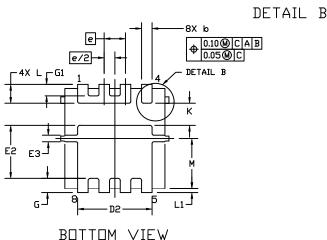
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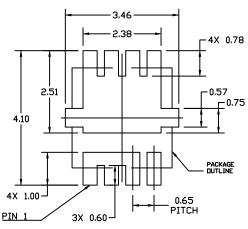






	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00		0.05		
ø	0.23	0.33	0.43		
n	0.15	0.20	0.25		
D	3.20	3.30	3.40		
D1	2.95	3.13	3.30		
DS	1.98	2.20	2.40		
Ε	3.20	3.30	3.40		
E1	2.80	3.00	3.15		
E2	1.40	1.60	1.80		
E3	0.15	0.25	0.40		
е		0.65 BSC			
O	0.30	0.43	0.55		
G1	0.25	0.35	0.45		
K	0.55	0.75	0.95		
L	0.35	0.52	0.65		
L1	0.06	0.15	0.30		
М	1.35	1.50	1.60		





# RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

## **GENERIC MARKING DIAGRAM\***

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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